## EE 505

## Lecture 17

## Current Steering DACs

# Current Steering DACs 

## Reduced Resistance Structure


$3 n+1$ cells


Is the R-2R structure smaller?
Does the R-2R structure perform better?
What metric should be used for comparing performance?

## Review from Last Lecture

## Performance of Thermometer Coded vs Binary Coded DACs

Conventional Wisdom:

- Thermometer-coded structures have inherently small DNL
- Binary coded structures can have large DNL
- INL of both structures is comparable for same total area


## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$
String DAC




Resistor Sigma $=14.14 \Omega$




Low DNL and random walk nature should be apparent

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$
$\mathrm{A}_{\mathrm{R}}=0.02 \mu \mathrm{~m}$
String DAC


INLkmax_mean =-2.11116e-05
INLkmax_sigma $=0.226783$

Histogram of $\mathrm{INL}_{\text {kmax }}$ from 100,000 runs
Appears to be Gaussian

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$
String DAC


INLmean $=0.384382$
INLsigma $=0.117732$

Histogram of INL from 100,000 runs
Not Gaussian

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$
Binary DAC




Resistor Sigma $=14.14 \Omega$



Large DNL bit INL does not appear to be much different than for string DAC

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$

$\mathrm{A}_{\mathrm{R}}=0.02 \mu \mathrm{~m}$<br>$\mathrm{R}_{\mathrm{N}}=1 \mathrm{~K}$

Resistor Sigma $=14.14 \Omega$
Both structures have essentially the same area

String DAC


Binary DAC


Histogram of INL from 100,000 runs
Since mathematical form for PDF is not available, not easy to analytically calculate yield

## Review from Last Lecture

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$

$\mathrm{A}_{\mathrm{R}}=0.02 \mu \mathrm{~m}$ $\mathrm{R}_{\mathrm{N}}=1 \mathrm{~K}$

Resistor Sigma $=14.14 \Omega$

Both structures have essentially the same area
String DAC

```
Resolution = 10
AR = 0.02
Rnom = 1000
Area Unit Resistor = 2 }\mu\mp@subsup{\textrm{m}}{}{2
INLkmax mean =-2.11116e-05
INLmean 0.384382
INLtarget = 0.5000
```

Nruns $=100000$
Resistor Sigma= 14.1421
INLkmax sigma $=0.226783$
INLsigma 0.117732
Yield(\%) $=84.0120$

Binary DAC

> Resolution $=10$ Rnom $=1000$ INLmean 0.367036
$\mathrm{AR}=0.02$
Rnom $=1000 \quad$ Area unit resistor $=2 \mu \mathrm{~m}^{2}$
INLkmax mean $=0.000130823$
DNL mean $=0.46978$
INLtarget $=0.5000$

Nruns $=100,000$
Resistor Sigma=14.1421
INLsigma 0.128294
INLkmax sigma $=0.226276$
DNLsigma $=0.227768$
Yield (\%) $=84.8580$

## Current Steering DACs



Segmented Resistor Arrays

- Combines two types of architectures
- Can inherit advantages of both thermometer and binary approach
- Minimizes limitations of both thermometer and binary approach


## Current Steering DACs

## Reduced Resistance Structure

Is it better to use series unary cells to form $R$ or parallel unary cells to form $\frac{R}{2^{n}}$ ?

$2^{n}-1$ cells

for $n$ odd $2^{\frac{n+3}{2}}-3$ cells

$2^{n}-1$ cells

| $n$ | Series | Parallel | Split |  |
| :---: | :---: | :---: | :---: | :---: |
| $\mathbf{3}$ |  | $\mathbf{7}$ | 7 | 5 |
| $\mathbf{5}$ |  | 31 | 31 | 13 |
| $\mathbf{7}$ |  | 127 | 127 | 29 |
| $\mathbf{9}$ |  | 511 | 511 | 61 |
| $\mathbf{1 1}$ |  | 2047 | 2047 | 125 |
| $\mathbf{1 3}$ |  | 8191 | 8191 | 253 |
| $\mathbf{1 5}$ |  | 32767 | 32767 | 509 |

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$
$\mathrm{A}_{\mathrm{R}}=0.02 \mu \mathrm{~m}$
$\mathrm{R}_{\mathrm{N}}=1 \mathrm{~K}$

String (Unary)


INLkmax_mean $=-.00526008$
INLkmax_sigma $=0.23196$

- Closed-Form Analytical Formulation Available

Resistor Sigma $=14.14 \Omega$
Binary DAC


INLmean $=0.368441$
INLsigma $=0.126133$

- No Closed-Form Analytical Formulation


## Comparison of Thermometer Coded and Binary Coded DACs

String (Unary)<br>

Binary DAC


Histogram of INL



These plots may be useful for providing insight into performance

## Comparison of Thermometer Coded and Binary Coded DACs

Example: $\mathrm{n}=10$
Binary DAC


Histogram of INL from 1000 runs

Resistor Sigma $=14.14 \Omega$
Binary DAC


Histogram of INL from 100,000 runs

Can require a large number of runs for useful information

## The R-2R Ladder

## R-2R Resistor Arrays



- Conceptually, area goes up linearly with number of bit slices
- Can be used in many different ways


## R-2R DAC


(4-bits shown)


By superposition:

$$
V_{O U T}=V_{R E F} d_{3} \cdot \frac{1}{2}+V_{\text {REF }} d_{2} \cdot \frac{1}{4}+V_{\text {REF }} d_{1} \cdot \frac{1}{8}+V_{\text {REF }} d_{0} \cdot \frac{1}{16}=V_{R E F} \sum_{k=0}^{3} \frac{d_{k}}{2^{4-k}}=V_{\text {REF }} \sum_{k=1}^{4} \frac{d_{4-k}}{2^{k}}
$$

- No op amp required !!
- 2:1 Ratio matching of MSB slice most critical
- Total resistance goes up linearly with number of bit slices !!
- Conventional wisdom: area goes up linearly with number of bit slices
- Does conventional wisdom result in optimal designs?


## R-2R DAC



Limitations:

- Parasitic capacitances on all nodes must settle during all transitions
- Switch impedances imbalance 2R cells
- Analogous to top-plate switching
- Output impedance not 0 Is the output impedance code dependent?




Large steps in output can occur How should area be allocated?

## R-2R Implementation



- Add resistor equal to nominal switch impedance in each unswitched cell
- Impedance equal to the nominal switch impedance
- Offers some improvement, particularly if all switches are bottom-plate switches (but for previous R-2R structure do not have all bottom-plate switches)
- Will not track with temperature and process variations


## R-2R Implementation



- Unit cell widely used
- Switch included in cell even if not switched!
- Code dependence of switch impedance of concern (this can be addressed)
- Delays associated with turning on switches also of concern since some cells not referenced to same level as switches


## R-2R Current Steering DAC



- INL can get large in R-2R structures
- DNL can get large in R-2R structures


## Sub-radix Array



$$
\text { Typically } \quad 2.1<\theta<2.5
$$

Termination resistor must be selected so that same attenuation is maintained Often only the first $n_{1}$ MSB "slices" will be sub-radix

Effective number of bits when using sub-radix array will be less than $k$
Can be calibrated to obtain very low DNL (and maybe INL) with small area

It can be shown that the optimal value of $z$ is given by the expression

$$
z=\frac{3 \theta+1-(1+\theta) \sqrt{1+4 \theta}}{-1+\sqrt{1+4 \theta}-2 \theta}
$$

This derivation is in a file named Termination of Subradix.docx
Derivation based upon assuming the three impedances $R_{1}$ below must be the same


Output of an optimally terminated subradix DAC of 5 bits with $\theta=2.5$ and $\mathrm{z}=1.15831$

See file SubRadix DAC.xslx

Chart Title

$\theta$ selected so probability of large positive gap is very small

## 3-slice sub-radix DAC



Typically $\theta$ is slightly greater than 2

Does not eliminate large DNL errors but can eliminate gaps in output

## R-2R Resistor Arrays



Does it make any difference how area is allocated?



2R Area twice R Area


R Area twice 2R Area

## Area Allocation for R and 2R Resistors



Series Layout



Parallel Layout


2R Area twice R Area


Assume area in each slice if fixed

## Area Allocation for R and 2 R Resistors




Yield is affected by both mean and standard deviation of the non-Gaussian pdf
Standard deviation of parallel layout is somewhat more (but uses less cells for n small)
Area allocation between slices also affects yield

## Challenges with all R-based DACs



- Switch Impedance
- Contact Resistance
- Variability

Resistor
Contact Resistance
Switch Impedance

- Parasitic Capacitances


## Another R-2R DAC



Eliminates series switch resistance when switching resistors
Series resistance in current source does not affect current
Must match both resistors and current sources
Current flow will pull capacitance on switch nodes to low before current sources leave saturation
Current flow will change power dissipation based upon digital code

## Another R-2R DAC



Switch will pull capacitance on switch nodes to GND instead of $\mathrm{V}_{\mathrm{SS}}$
Power dissipation will not be code dependent

## Current Steering DAC



- Switch impedance of little concern
- Bottom-plate switching
- Low DNL
- Decoder impractical for large n


## Current Steering Binary DAC



- eliminates decoder
- DNL not good for large n
- area ratio from MSB source to LSB source too large for large n (can make I only so small)


## Current Steering Binary DAC



- reduces total current spread of bit cells
- reduces total number of bit cells (since cells are bundeded
- can repeat mirror current attenuator
- can change number of bits in each current attenuator stage

How is performance affected by reducing the number of unary cells? Is too much area allocated to the LSB cells?

## Current Steering Binary DAC



- LSB performance not critical
- Limit number of binary attenuators to avoid accumulating too much error


## Sub-Radix Current Steering DAC



Typically $1.9<\theta<1.99$ (Depending on ratio-matching accuracy of current sources)
Takes smaller steps so takes more steps to cover range

## Current Steering DAC



## Current Steering DAC



Bottom plate switching
Is output impedance of current sources of concern?


No! Matching is important but linearity is not

## Current Steering DAC



Power dissipation is code dependent

## Current Steering DAC



- Current steering instead of current switching
- Power dissipation in current sources remains constant
- Smaller gate voltages can be used to steer current


Differential Amplifier (Analog)

- Dump current can provide differential DAC output


## Current Steering DAC



- Parasitic capacitances do not charge and discharge
- Current steering provides inherent cascading
- This structure is a double-cascode



## Current Steering DAC



Signal swings only need to be large enough to steer current

## Current Steering DAC with Supply Independent Biasing



If transistors on top row are all matched, $\mathrm{I}_{\mathrm{X}}=\mathrm{V}_{\mathrm{REF}} / \mathrm{R}$
Thermometer coded structure (requires binary to thermometer decoder)

$$
\mathrm{I}_{\mathrm{A}}=\left(\frac{\mathrm{V}_{\mathrm{REF}}}{\mathrm{R}}\right) \sum_{\mathrm{i}=0}^{\mathrm{N}-1} \mathrm{~d}_{\mathrm{i}}
$$

Provides Differential Output Currents

## Current Steering DAC with Supply Independent Biasing



If transistors on top row are all matched, $\mathrm{I}_{\mathrm{X}}=\mathrm{V}_{\mathrm{REF}} / \mathrm{R}$

$$
V_{A}=\left(-V_{R E F} \frac{R_{A}}{R}\right) \sum_{i=0}^{N-1} d_{i}
$$

Provides Differential Output Voltages

## Current Current Steering DAC with Supply Independent Biasing



If transistors on top row are binary weighted

$$
\mathrm{I}_{\mathrm{A}}=\left(\frac{\mathrm{V}_{\mathrm{REF}}}{\mathrm{R}}\right) \sum_{\mathrm{i}=0}^{\mathrm{n}-1} \frac{\mathrm{~d}_{\mathrm{i}}}{2^{\mathrm{n}-\mathrm{i}}}
$$

Provides Differential Output Currents
Does this serve as an MDAC?

## surrentinernern



- Many current steering DACs have an output current instead of an output voltage
- Output voltage is often established by steering current to a fixed external resistor ( $50 \Omega$ or $100 \Omega$ )
- Most basic current steering architectures with a high output impedance can be used by simply removing the op amp
- Whereas output impedance of current sources was not of major concern when driving a null-port, it can be of major concern for current output
- Speed may improve and power dissipation may decrease in internal circuitry if output is current



## Stay Safe and Stay Healthy !

## End of Lecture 17

